Advance Information

Power MOSFET

25 V, 58 A, Single N- Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	25	V		
Gate-to-Source Voltage	е		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	11.5	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		9.0	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.0	W
Continuous Drain		T _A = 25°C	I _D	9.0	Α
Current (R _{θJA}) (Note 2)	Steady	T _A = 85°C		7.0	
Power Dissipation (R _{θJA}) (Note 2)	State	T _A = 25°C	P _D	1.3	W
Continuous Drain		T _C = 25°C	I _D	58	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		45	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T _C = 25°C	P _D	52	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	130	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and	T _J , T _{stg}	-55 to 175	°C		
Source Current (Body Di	ode)		I _S	43	Α
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 20 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 13.5 A, R_G = 25 Ω)			E _{AS}	91.0	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

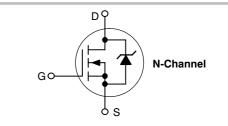
This document contains information on a new product. Specifications and information herein are subject to change without notice.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} MAX	
25.\/	9.0 mΩ @ 10 V	58 A
25 V	14 mΩ @ 4.5 V	30 A







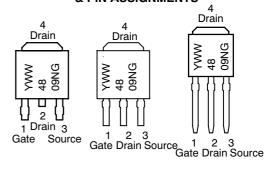


DPAK (Bend Lead) CASE 369C STYLE 2

3 IPAK (Straight Lead) CASE 369AD

DPAK (Straight Lead) CASE 369D STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS



Y = Year WW = Work Week 4809N = Device Code G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.9	°C/W
Junction-to-T AB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	74	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	116	

- Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			1.0 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)		-			1		ı
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	I _D = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to	I _D = 30 A		7.0	9.0	mΩ
		11.5 V	I _D = 15 A		7.0		
		V _{GS} = 4.5 V	I _D = 30 A		12	14	
			I _D = 15 A		11		1
Forward Transconductance	9FS	V _{DS} = 15 V	, I _D = 15 A		9.0		S
CHARGES AND CAPACITANCES	•		•		•	•	
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			1456		pF
Output Capacitance	C _{oss}				315		
Reverse Transfer Capacitance	C _{rss}	₹ D5 −	12 V		200		
Total Gate Charge	Q _{G(TOT)}				11	13	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V,	V _{DS} = 15 V,		2.5		-
Gate-to-Source Charge	Q_{GS}	I _D = 3			4.8		
Gate-to-Drain Charge	Q_{GD}				5.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, I _D = 3			25		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(on)}				12.3		ns
Rise Time	t _r	V _{GS} = 4.5 V,	V _{DS} = 15 V,		21.3		
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, F	$R_{G} = 3.0 \Omega$		15.1		1
Fall Time	t _f				5.3		
Turn-On Delay Time	t _{d(on)}				7.0		ns
Rise Time	t _r	V _{GS} = 11.5 V,	V _{DS} = 15 V,		22.7		1
Turn-Off Delay Time	t _{d(off)}	$I_{D} = 15 \text{ A}, F$			25.3		
Fall Time	t _f				2.8		1

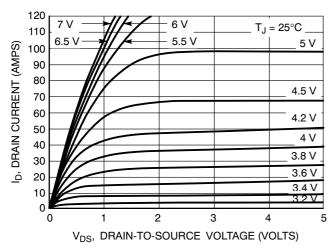
- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERIS							
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$	T _J = 25°C		0.95	1.2	V
		I _S = 30 A	T _J = 125°C		0.83		
Reverse Recovery Time	t _{RR}				19.5		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls/}$	V _{GS} = 0 V, dIs/dt = 100 A/μs,		10.7		
Discharge Time	tb	I _S = 30 A			8.8		
Reverse Recovery Time	Q _{RR}				9.2		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nH
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		
Gate Inductance	L _G				3.46		
Gate Resistance	R_{G}				2.4		Ω

TYPICAL PERFORMANCE CURVES

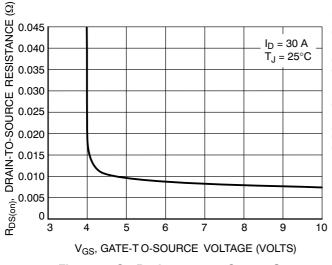
120



 $V_{DS} \ge 10 \text{ V}$ DRAIN CURRENT (AMPS) 100 80 60 40 T_J = 125°C $T_J = 25^{\circ}C$ ث 20 $T_J = -55^{\circ}C$ 0 0 2 3 5 6 V_{GS}, GATE-T O-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



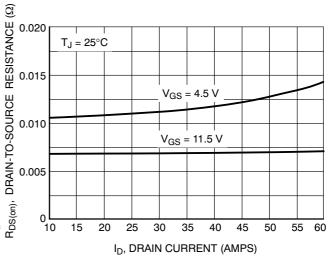
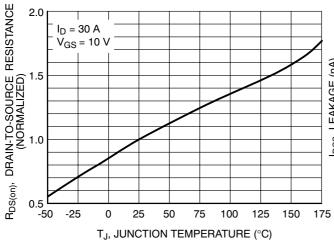


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



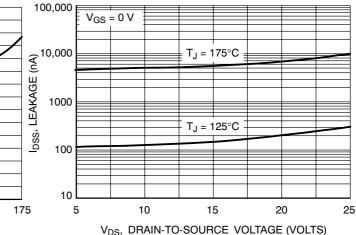
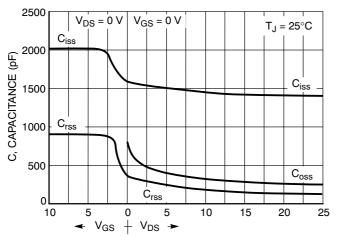


Figure 5. On-Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE- TO- SOURCE OR DRAIN- TO- SOURCE VOLTAGE (VOLTS)

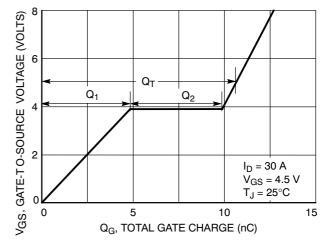


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



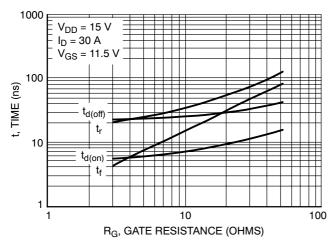


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

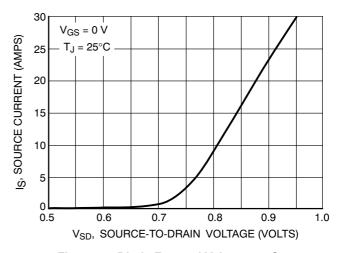


Figure 10. Diode Forward Voltage vs. Current

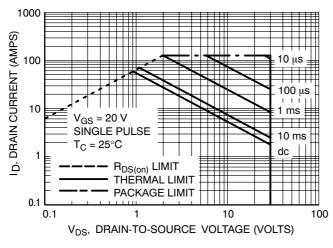


Figure 11. Maximum Rated Forward Biased Safe Operating Area

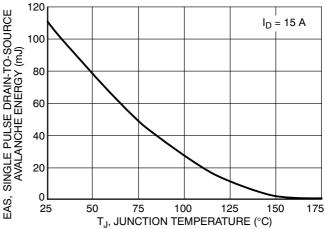


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

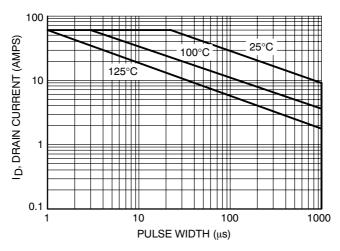


Figure 13. Avalanche Characteristics

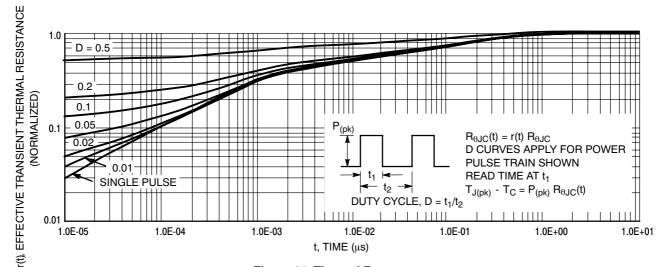


Figure 14. Thermal Response

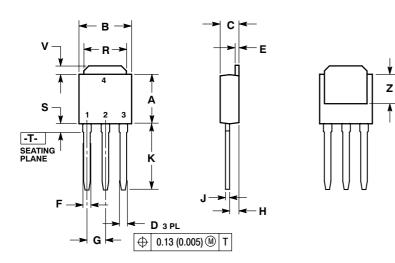
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4809NAG	DPAK (Pb-Free)	75 Units/Rail
NTD4809NAT4G	DPAK (Pb-Free)	2500 Tape & Reel
NTD4809NA-1G	IPAK (Pb-Free)	75 Units/Rail
NTD4809NA-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units/Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK CASE 369D-01 **ISSUE B**



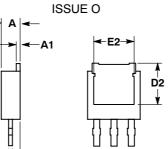
- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

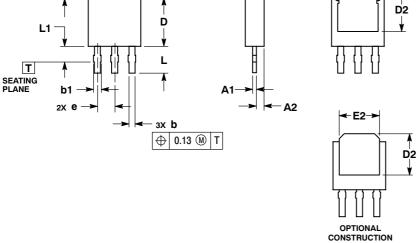
	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
7	0 155		3 93	

STYLE 2:

- PIN 1. GATE 2. DRAIN 3. SOURCE
 - 4. DRAIN

3.5 MM IPAK, STRAIGHT LEAD CASE 369AD-01





NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.

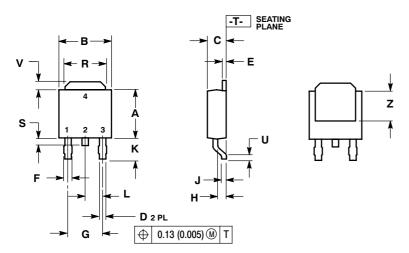
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIMETERS				
DIM	MIN	MAX			
Α	2.19	2.38			
A1	0.46	0.60			
A2	0.87	1.10			
b	0.69	0.89			
b1	0.77	1.10			
D	5.97	6.22			
D2	4.80				
Е	6.35	6.73			
E2	4.70				
E3	4.45	5.46			
е	2.28	BSC			
L	3.40	3.60			
L1		2.10			
L2	0.89	1.27			

PACKAGE DIMENSIONS

DPAK

CASE 369C-01 **ISSUE O**

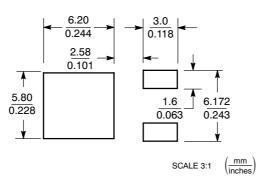


NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090	0.090 BSC		BSC
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3 93	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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